



# BF1205C

Dual N-channel dual gate MOS-FET

Rev. 02 — 15 August 2006

Product data sheet

## 1. Product profile

### 1.1 General description

The BF1205C is a combination of two dual gate MOS-FET amplifiers with shared source and gate 2 leads and an integrated switch. The integrated switch is operated by the gate 1 bias of amplifier b.

The source and substrate are interconnected. Internal bias circuits enable DC stabilization and a very good cross-modulation performance during AGC. Integrated diodes between the gates and source protect against excessive input voltage surges. The transistor has a SOT363 micro-miniature plastic package.

#### CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

### 1.2 Features

- Two low noise gain controlled amplifiers in a single package; one with a fully integrated bias and one with a partly integrated bias
- Internal switch to save external components
- Superior cross-modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio.

### 1.3 Applications

- Gain controlled low noise amplifiers for VHF and UHF applications with 5 V supply voltage
  - ◆ digital and analog television tuners
  - ◆ professional communication equipment.

# PHILIPS

**1.4 Quick reference data**

**Table 1. Quick reference data**  
Per MOS-FET unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{DS}$	drain-source voltage		-	-	6	V
$I_D$	drain current (DC)		-	-	30	mA
$P_{tot}$	total power dissipation	$T_{sp} \leq 107\text{ }^\circ\text{C}$	[1]	-	180	mW
$ y_{fs} $	forward transfer admittance	$f = 1\text{ MHz}$				
		amplifier a; $I_D = 19\text{ mA}$	26	31	41	mS
		amplifier b; $I_D = 13\text{ mA}$	28	33	43	mS
$C_{ig1-ss}$	input capacitance at gate 1	$f = 1\text{ MHz}$				
		amplifier a	-	2.2	2.7	pF
		amplifier b	-	2.0	2.5	pF
$C_{rss}$	reverse transfer capacitance	$f = 1\text{ MHz}$	-	20	-	fF
NF	noise figure	amplifier a; $f = 400\text{ MHz}$	-	1.3	1.9	dB
		amplifier b; $f = 800\text{ MHz}$	-	1.4	2.1	dB
$X_{mod}$	cross-modulation	input level for $k = 1\%$ at 40 dB AGC				
		amplifier a	100	105	-	dB $\mu$ V
		amplifier b	100	103	-	dB $\mu$ V
$T_j$	junction temperature		-	-	150	$^\circ\text{C}$

[1]  $T_{sp}$  is the temperature at the soldering point of the source lead.

**2. Pinning information**

**Table 2. Discrete pinning**

Pin	Description	Simplified outline	Symbol
1	gate 1 (a)	<p>001aaa706</p>	<p>sym033</p>
2	gate 2		
3	gate 1 (b)		
4	drain (b)		
5	source		
6	drain (a)		

### 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BF1205C	-	plastic surface mounted package; 6 leads	SOT363

### 4. Marking

Table 4. Marking

Type number	Marking code <sup>[1]</sup>
BF1205C	M6*

- [1] \* = p or -: made in Hong Kong.  
 \* = t: made in Malaysia.  
 \* = W: made in China.

### 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
<b>Per MOS-FET</b>					
$V_{DS}$	drain-source voltage		-	6	V
$I_D$	drain current (DC)		-	30	mA
$I_{G1}$	gate 1 current		-	±10	mA
$I_{G2}$	gate 2 current		-	±10	mA
$P_{tot}$	total power dissipation	$T_{sp} \leq 107\text{ °C}$ <sup>[1]</sup>	-	180	mW
$T_{stg}$	storage temperature		-65	+150	°C
$T_j$	junction temperature		-	150	°C

- [1]  $T_{sp}$  is the temperature at the soldering point of the source lead.

### 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-s)}$	thermal resistance from junction to soldering point		240	K/W

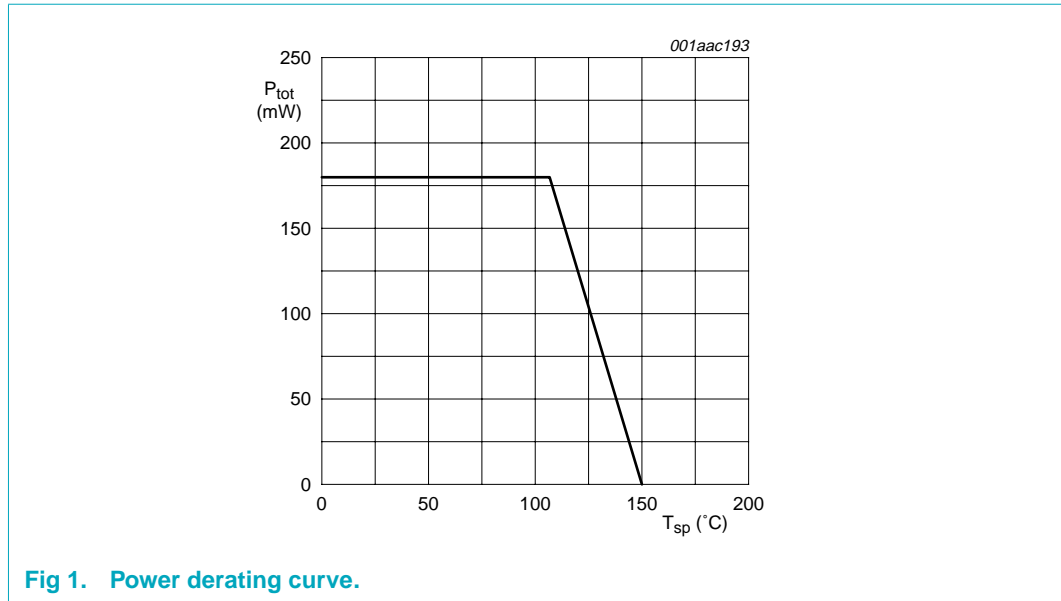


Fig 1. Power derating curve.

## 7. Static characteristics

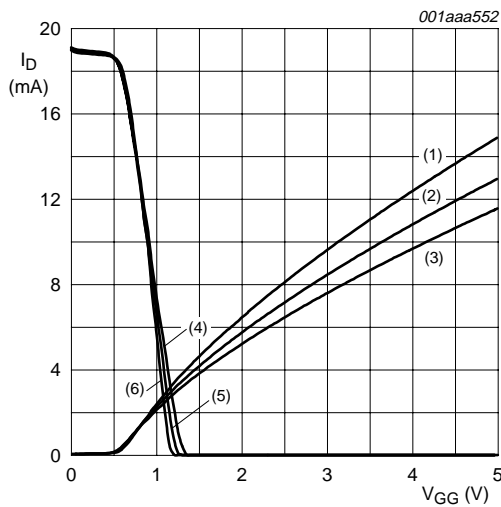
Table 7. Static characteristics

T<sub>j</sub> = 25 °C.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Per MOS-FET; unless otherwise specified</b>						
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	V <sub>G1-S</sub> = V <sub>G2-S</sub> = 0 V; I <sub>D</sub> = 10 μA				
		amplifier a	6	-	-	V
		amplifier b	6	-	-	V
V <sub>(BR)G1-SS</sub>	gate 1-source breakdown voltage	V <sub>GS</sub> = V <sub>DS</sub> = 0 V; I <sub>G1-S</sub> = 10 mA	6	-	10	V
V <sub>(BR)G2-SS</sub>	gate 2-source breakdown voltage	V <sub>GS</sub> = V <sub>DS</sub> = 0 V; I <sub>G2-S</sub> = 10 mA	6	-	10	V
V <sub>(F)S-G1</sub>	forward source-gate 1 voltage	V <sub>G2-S</sub> = V <sub>DS</sub> = 0 V; I <sub>S-G1</sub> = 10 mA	0.5	-	1.5	V
V <sub>(F)S-G2</sub>	forward source-gate 2 voltage	V <sub>G1-S</sub> = V <sub>DS</sub> = 0 V; I <sub>S-G2</sub> = 10 mA	0.5	-	1.5	V
V <sub>G1-S(th)</sub>	gate 1-source threshold voltage	V <sub>DS</sub> = 5 V; V <sub>G2-S</sub> = 4 V; I <sub>D</sub> = 100 μA	0.3	-	1.0	V
V <sub>G2-S(th)</sub>	gate 2-source threshold voltage	V <sub>DS</sub> = 5 V; V <sub>G1-S</sub> = 5 V; I <sub>D</sub> = 100 μA	0.4	-	1.0	V
I <sub>DSX</sub>	drain-source current	V <sub>G2-S</sub> = 4 V; V <sub>DS(b)</sub> = 5 V; R <sub>G1</sub> = 150 kΩ				
		amplifier a; V <sub>DS(a)</sub> = 5 V	[1] 14	-	24	mA
		amplifier b	[2] 9	-	17	mA
I <sub>G1-S</sub>	gate 1 cut-off current	V <sub>G2-S</sub> = V <sub>DS(a)</sub> = 0 V				
		amplifier a; V <sub>G1-S(a)</sub> = 5 V; I <sub>D(b)</sub> = 0 A	-	-	50	nA
		amplifier b; V <sub>G1-S(b)</sub> = 5 V; V <sub>DS(b)</sub> = 0 V	-	-	50	nA
I <sub>G2-S</sub>	gate 2 cut-off current	V <sub>G2-S</sub> = 4 V; V <sub>G1-S(a)</sub> = V <sub>DS(a)</sub> = V <sub>DS(b)</sub> = 0 V; V <sub>G1-S(b)</sub> = 0 V;	-	-	20	nA

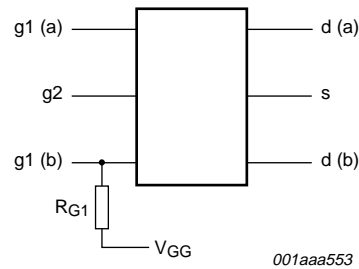
[1] R<sub>G1</sub> connects gate 1 (b) to V<sub>GG</sub> = 0 V (see Figure 3).

[2] R<sub>G1</sub> connects gate 1 (b) to V<sub>GG</sub> = 5 V (see Figure 3).



- (1)  $I_{D(b)}$ ;  $R_{G1} = 120 \text{ k}\Omega$ .
- (2)  $I_{D(b)}$ ;  $R_{G1} = 150 \text{ k}\Omega$ .
- (3)  $I_{D(b)}$ ;  $R_{G1} = 180 \text{ k}\Omega$ .
- (4)  $I_{D(a)}$ ;  $R_{G1} = 180 \text{ k}\Omega$ .
- (5)  $I_{D(a)}$ ;  $R_{G1} = 150 \text{ k}\Omega$ .
- (6)  $I_{D(a)}$ ;  $R_{G1} = 120 \text{ k}\Omega$ .

Fig 2. Drain currents of MOS-FET a and b as function of  $V_{GG}$ .



$V_{GG} = 5 \text{ V}$ : amplifier a is off; amplifier b is on  
 $V_{GG} = 0 \text{ V}$ : amplifier a is on; amplifier b is off.

Fig 3. Functional diagram.

## 8. Dynamic characteristics

### 8.1 Dynamic characteristics for amplifier a

Table 8. Dynamic characteristics for amplifier a[1]

Common source;  $T_{amb} = 25 \text{ }^\circ\text{C}$ ;  $V_{G2-S} = 4 \text{ V}$ ;  $V_{DS} = 5 \text{ V}$ ;  $I_D = 19 \text{ mA}$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$ y_{fs} $	forward transfer admittance	$T_j = 25 \text{ }^\circ\text{C}$	26	31	41	mS
$C_{ig1-ss}$	input capacitance at gate 1	$f = 1 \text{ MHz}$	-	2.2	2.7	pF
$C_{ig2-ss}$	input capacitance at gate 2	$f = 1 \text{ MHz}$	-	3.0	-	pF
$C_{oss}$	output capacitance	$f = 1 \text{ MHz}$	-	0.9	-	pF
$C_{rss}$	reverse transfer capacitance	$f = 1 \text{ MHz}$	-	20	-	fF
$G_{tr}$	power gain	$B_S = B_{S(opt)}$ ; $B_L = B_{L(opt)}$				
		$f = 200 \text{ MHz}$ ; $G_S = 2 \text{ mS}$ ; $G_L = 0.5 \text{ mS}$	31	35	39	dB
		$f = 400 \text{ MHz}$ ; $G_S = 2 \text{ mS}$ ; $G_L = 1 \text{ mS}$	26	30	34	dB
		$f = 800 \text{ MHz}$ ; $G_S = 3.3 \text{ mS}$ ; $G_L = 1 \text{ mS}$	21	25	29	dB
NF	noise figure	$f = 11 \text{ MHz}$ ; $G_S = 20 \text{ mS}$ ; $B_S = 0 \text{ S}$	-	3.0	-	dB
		$f = 400 \text{ MHz}$ ; $Y_S = Y_{S(opt)}$	-	1.3	1.9	dB
		$f = 800 \text{ MHz}$ ; $Y_S = Y_{S(opt)}$	-	1.4	2.1	dB

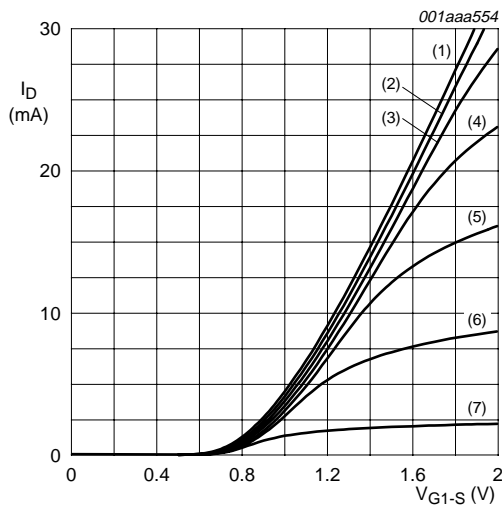
**Table 8. Dynamic characteristics for amplifier a** [1] ...continued  
Common source;  $T_{amb} = 25\text{ }^{\circ}\text{C}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $V_{DS} = 5\text{ V}$ ;  $I_D = 19\text{ mA}$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$X_{mod}$	cross-modulation	input level for $k = 1\%$ ; $f_w = 50\text{ MHz}$ ; $f_{unw} = 60\text{ MHz}$ [2]				
		at 0 dB AGC	90	-	-	dB $\mu$ V
		at 10 dB AGC	-	90	-	dB $\mu$ V
		at 20 dB AGC	-	99	-	dB $\mu$ V
		at 40 dB AGC	100	105	-	dB $\mu$ V

[1] For the MOS-FET not in use:  $V_{G1-S(b)} = 0\text{ V}$ ;  $V_{DS(b)} = 0\text{ V}$ .

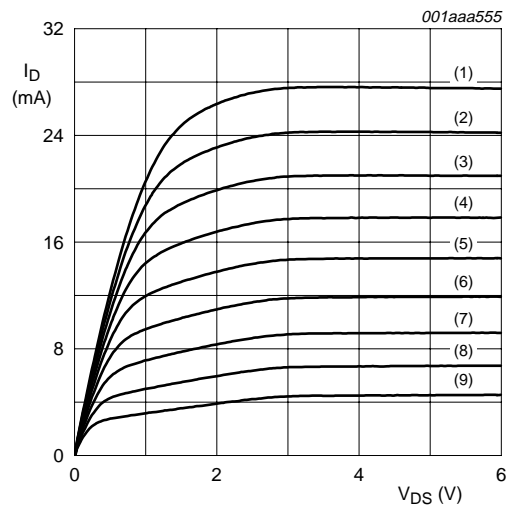
[2] Measured in Figure 33 test circuit.

### 8.1.1 Graphs for amplifier a



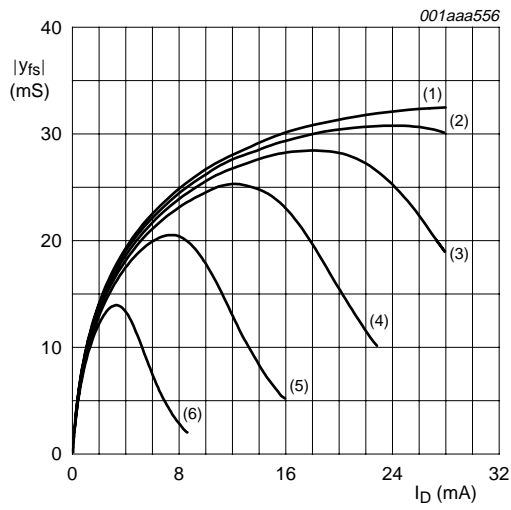
- (1)  $V_{G2-S} = 4\text{ V}$ .
  - (2)  $V_{G2-S} = 3.5\text{ V}$ .
  - (3)  $V_{G2-S} = 3\text{ V}$ .
  - (4)  $V_{G2-S} = 2.5\text{ V}$ .
  - (5)  $V_{G2-S} = 2\text{ V}$ .
  - (6)  $V_{G2-S} = 1.5\text{ V}$ .
  - (7)  $V_{G2-S} = 1\text{ V}$ .
- $V_{DS(a)} = 5\text{ V}$ ;  $V_{G1-S(b)} = V_{DS(b)} = 0\text{ V}$ ;  $T_j = 25\text{ }^{\circ}\text{C}$ .

Fig 4. Transfer characteristics; typical values.



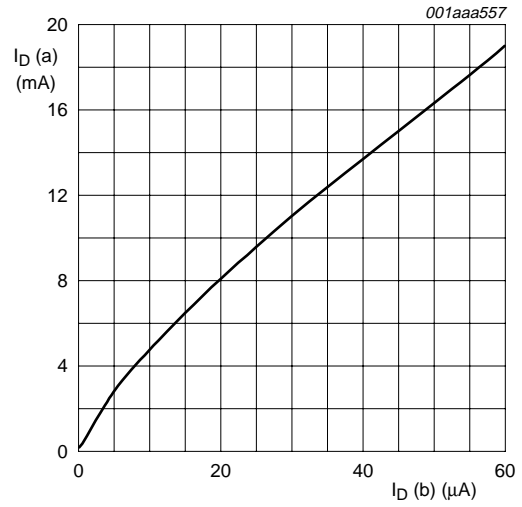
- (1)  $V_{G1-S(a)} = 1.8\text{ V}$ .
  - (2)  $V_{G1-S(a)} = 1.7\text{ V}$ .
  - (3)  $V_{G1-S(a)} = 1.6\text{ V}$ .
  - (4)  $V_{G1-S(a)} = 1.5\text{ V}$ .
  - (5)  $V_{G1-S(a)} = 1.4\text{ V}$ .
  - (6)  $V_{G1-S(a)} = 1.3\text{ V}$ .
  - (7)  $V_{G1-S(a)} = 1.2\text{ V}$ .
  - (8)  $V_{G1-S(a)} = 1.1\text{ V}$ .
  - (9)  $V_{G1-S(a)} = 1\text{ V}$ .
- $V_{G2-S} = 4\text{ V}$ ;  $V_{G1-S(b)} = V_{DS(b)} = 0\text{ V}$ ;  $T_j = 25\text{ }^{\circ}\text{C}$ .

Fig 5. Output characteristics; typical values.



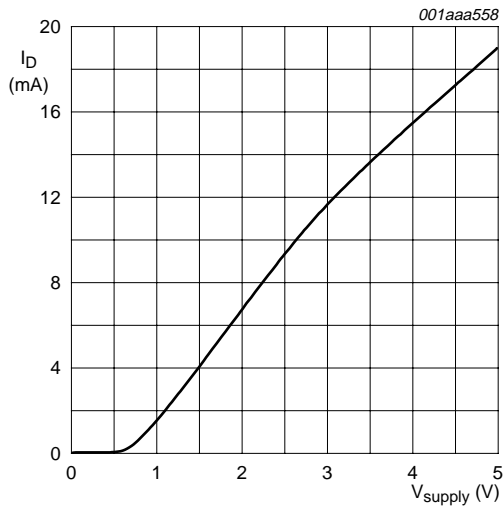
- (1)  $V_{G2-S} = 4 \text{ V}$ .
  - (2)  $V_{G2-S} = 3.5 \text{ V}$ .
  - (3)  $V_{G2-S} = 3 \text{ V}$ .
  - (4)  $V_{G2-S} = 2.5 \text{ V}$ .
  - (5)  $V_{G2-S} = 2 \text{ V}$ .
  - (6)  $V_{G2-S} = 1.5 \text{ V}$ .
- $V_{DS(a)} = 5 \text{ V}; V_{G1-S(b)} = V_{DS(b)} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$ .

**Fig 6. Forward transfer admittance as a function of drain current; typical values.**



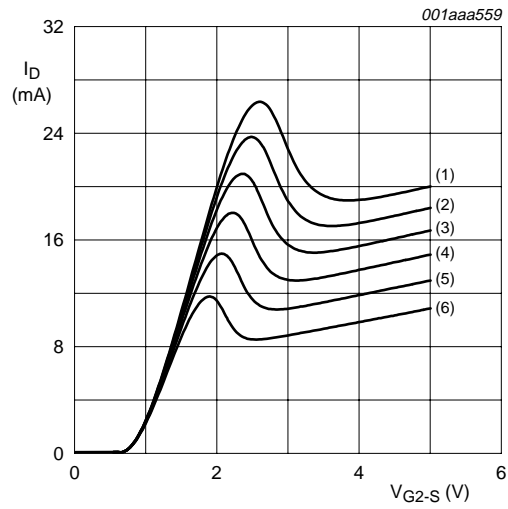
- $V_{DS(a)} = 5 \text{ V}; V_{G2-S} = 4 \text{ V}; V_{DS(b)} = 5 \text{ V};$   
 $V_{G1-S(b)} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$ .

**Fig 7. Drain current as a function of internal G1 current (current in pin drain (b) if MOS-FET (b) is switched off); typical values.**



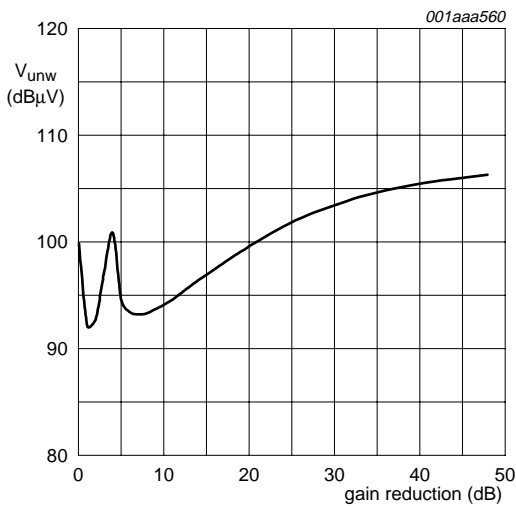
$V_{DS(a)} = V_{DS(b)} = V_{supply}$ ,  $V_{G2-S} = 4\text{ V}$ ,  $T_j = 25\text{ }^\circ\text{C}$ ,  
 $R_{G1(b)} = 150\text{ k}\Omega$  (connected to ground); see [Figure 3](#).

**Fig 8.** Drain current of amplifier a as a function of supply voltage of a and b amplifier; typical values.



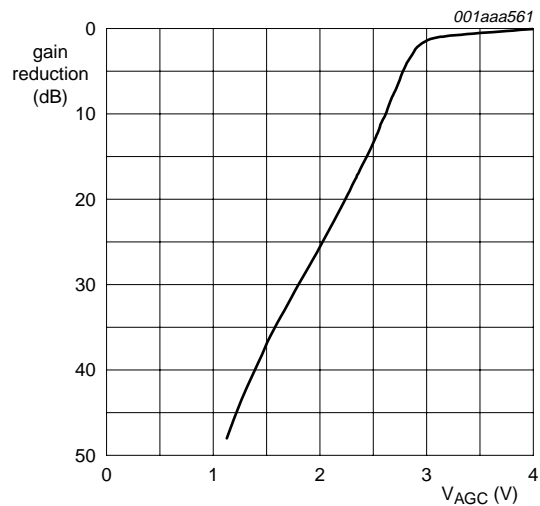
(1)  $V_{DS(b)} = 5\text{ V}$ .  
 (2)  $V_{DS(b)} = 4.5\text{ V}$ .  
 (3)  $V_{DS(b)} = 4\text{ V}$ .  
 (4)  $V_{DS(b)} = 3.5\text{ V}$ .  
 (5)  $V_{DS(b)} = 3\text{ V}$ .  
 (6)  $V_{DS(b)} = 2.5\text{ V}$ .  
 $V_{DS(a)} = 5\text{ V}$ ;  $V_{G1-S(b)} = 0\text{ V}$ ; gate 1 (a) = open;  
 $T_j = 25\text{ }^\circ\text{C}$ .

**Fig 9.** Drain current as a function of gate 2 and drain supply voltage; typical values.



$V_{DS(a)} = V_{DS(b)} = 5\text{ V}$ ;  $V_{G1-S(b)} = 0\text{ V}$ ;  $f_w = 50\text{ MHz}$ ;  
 $f_{unw} = 60\text{ MHz}$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ ; see [Figure 33](#).

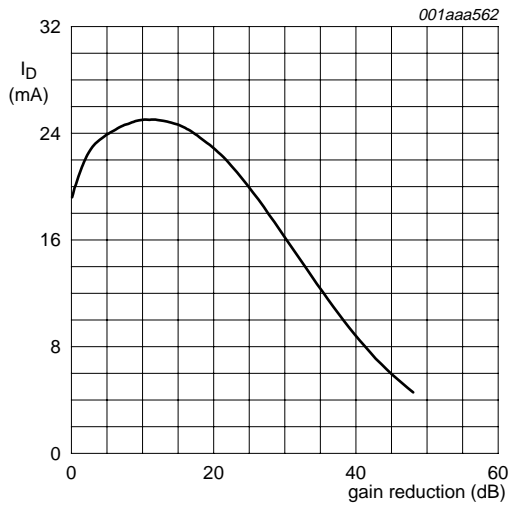
**Fig 10.** Unwanted voltage for 1 % cross-modulation as a function of gain reduction; typical values.



$V_{DS(a)} = V_{DS(b)} = 5\text{ V}$ ;  $V_{G1-S(b)} = 0\text{ V}$ ;  $f = 50\text{ MHz}$ ; see [Figure 33](#).

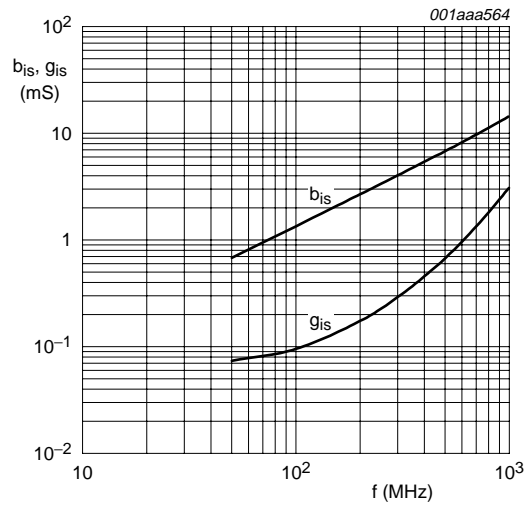
**Fig 11.** Gain reduction as a function of AGC voltage; typical values.





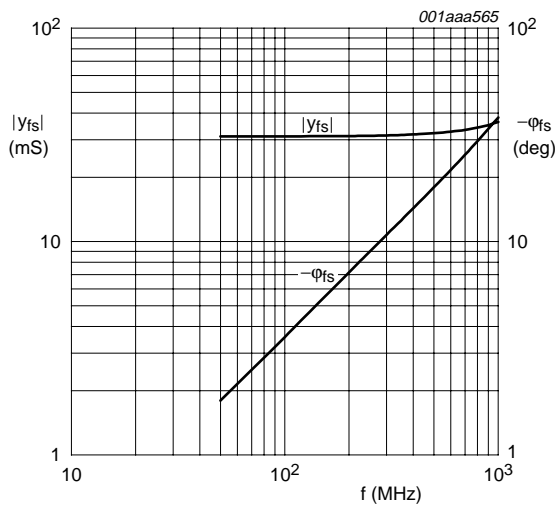
$V_{DS(a)} = V_{DS(b)} = 5\text{ V}$ ;  $V_{G1-S(b)} = 0\text{ V}$ ;  $f = 50\text{ MHz}$ ;  
 $T_{amb} = 25\text{ }^\circ\text{C}$ ; see [Figure 33](#).

Fig 12. Drain current as a function of gain reduction; typical values.



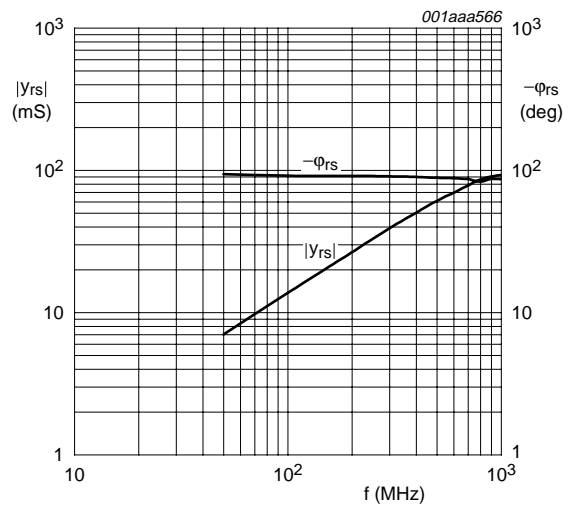
$V_{DS(a)} = 5\text{ V}$ ;  $V_{G2-S(a)} = 4\text{ V}$ ;  $V_{DS(b)} = V_{G1-S(b)} = 0\text{ V}$ ;  
 $I_{D(a)} = 19\text{ mA}$ .

Fig 13. Input admittance as a function of frequency; typical values.



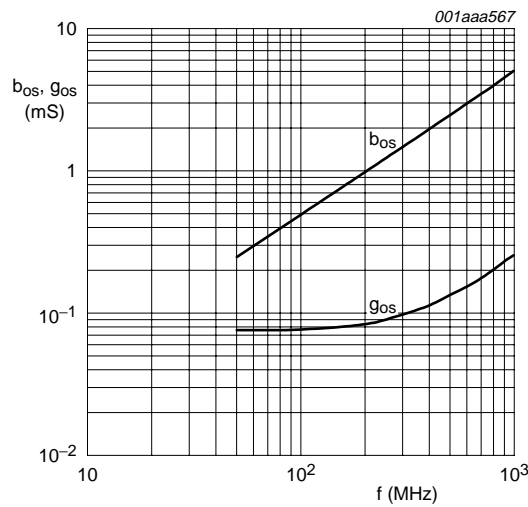
$V_{DS(a)} = 5\text{ V}$ ;  $V_{G2-S(a)} = 4\text{ V}$ ;  $V_{DS(b)} = V_{G1-S(b)} = 0\text{ V}$ ;  
 $I_{D(a)} = 19\text{ mA}$ .

Fig 14. Forward transfer admittance and phase as a function of frequency; typical values.



$V_{DS(a)} = 5\text{ V}$ ;  $V_{G2-S(a)} = 4\text{ V}$ ;  $V_{DS(b)} = V_{G1-S(b)} = 0\text{ V}$ ;  
 $I_{D(a)} = 19\text{ mA}$ .

Fig 15. Reverse transfer admittance and phase as a function of frequency; typical values.



$V_{DS(a)} = 5\text{ V}$ ;  $V_{G2-S(a)} = 4\text{ V}$ ;  $V_{DS(b)} = V_{G1-S(b)} = 0\text{ V}$ ;  $I_{D(a)} = 19\text{ mA}$ .

**Fig 16. Output admittance as a function of frequency; typical values.**

### 8.1.2 Scattering parameters for amplifier a

**Table 9. Scattering parameters for amplifier a**

$V_{DS(a)} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_{D(a)} = 19\text{ mA}$ ;  $V_{DS(b)} = 0\text{ V}$ ;  $V_{G-1S(b)} = 0\text{ V}$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ .

f (MHz)	S <sub>11</sub>		S <sub>21</sub>		S <sub>12</sub>		S <sub>22</sub>	
	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)
50	0.992	-3.91	3.07	175.56	0.0007	83.61	0.992	-1.47
100	0.990	-7.76	3.06	171.18	0.0017	83.19	0.992	-2.93
200	0.982	-15.42	3.04	162.42	0.0026	78.19	0.990	-5.84
300	0.971	-22.99	3.01	153.79	0.0037	73.75	0.988	-8.71
400	0.956	-30.52	2.96	145.22	0.0047	69.82	0.985	-11.59
500	0.938	-37.83	2.90	136.78	0.0055	66.12	0.982	-14.48
600	0.917	-45.14	2.83	128.46	0.0061	62.11	0.979	-17.31
700	0.893	-52.31	2.76	120.20	0.0065	58.86	0.975	-20.14
800	0.867	-59.47	2.69	111.98	0.0068	58.28	0.972	-22.98
900	0.838	-66.23	2.60	103.90	0.0067	50.64	0.968	-25.85
1000	0.807	-73.10	2.52	95.875	0.0065	47.28	0.966	-28.74

### 8.1.3 Noise data for amplifier a

**Table 10. Noise data for amplifier a**

$V_{DS(a)} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_{D(a)} = 19\text{ mA}$ ;  $V_{DS(b)} = 0\text{ V}$ ;  $V_{G-1S(b)} = 0\text{ V}$ ;  $T_{amb} = 25\text{ }^\circ\text{C}$ .

f (MHz)	F <sub>min</sub> (dB)	Γ <sub>opt</sub>		r <sub>n</sub> (Ω)
		ratio	(deg)	
400	1.3	0.718	16.06	0.683
800	1.4	0.677	37.59	0.681

## 8.2 Dynamic characteristics for amplifier b

**Table 11. Dynamic characteristics for amplifier b**

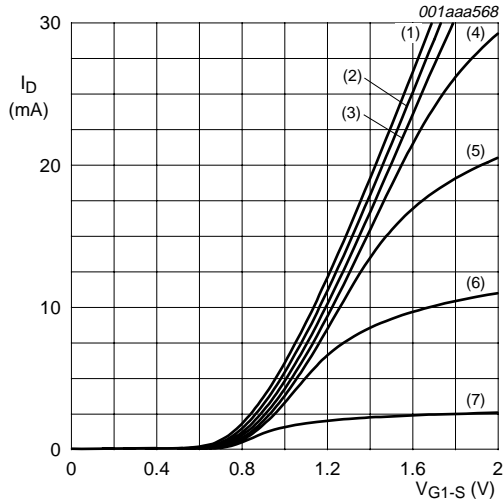
Common source;  $T_{amb} = 25\text{ °C}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $V_{DS} = 5\text{ V}$ ;  $I_D = 13\text{ mA}$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$ y_{fs} $	forward transfer admittance	$T_j = 25\text{ °C}$	28	33	43	mS
$C_{ig1-ss}$	input capacitance at gate 1	$f = 1\text{ MHz}$	-	2.0	2.5	pF
$C_{ig2-ss}$	input capacitance at gate 2	$f = 1\text{ MHz}$	-	3.4	-	pF
$C_{oss}$	output capacitance	$f = 1\text{ MHz}$	-	0.85	-	pF
$C_{rss}$	reverse transfer capacitance	$f = 1\text{ MHz}$	-	20	-	fF
$G_{tr}$	power gain	$B_S = B_{S(opt)}$ ; $B_L = B_{L(opt)}$	[1]			
		$f = 200\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $G_L = 0.5\text{ mS}$	31	35	39	dB
		$f = 400\text{ MHz}$ ; $G_S = 2\text{ mS}$ ; $G_L = 1\text{ mS}$	28	32	36	dB
		$f = 800\text{ MHz}$ ; $G_S = 3.3\text{ mS}$ ; $G_L = 1\text{ mS}$	24	28	32	dB
NF	noise figure	$f = 11\text{ MHz}$ ; $G_S = 20\text{ mS}$ ; $B_S = 0\text{ S}$	-	5	-	dB
		$f = 400\text{ MHz}$ ; $Y_S = Y_{S(opt)}$	-	1.3	1.9	dB
		$f = 800\text{ MHz}$ ; $Y_S = Y_{S(opt)}$	-	1.4	2.1	dB
$X_{mod}$	cross-modulation	input level for $k = 1\%$ ; $f_w = 50\text{ MHz}$ ; $f_{unw} = 60\text{ MHz}$	[2]			
		at 0 dB AGC	90	-	-	dB $\mu$ V
		at 10 dB AGC	-	88	-	dB $\mu$ V
		at 20 dB AGC	-	94	-	dB $\mu$ V
		at 40 dB AGC	100	103	-	dB $\mu$ V

[1] For the MOS-FET not in use:  $V_{G1-S(a)} = 0\text{ V}$ ;  $V_{DS(a)} = 0\text{ V}$ .

[2] Measured in [Figure 34](#) test circuit.

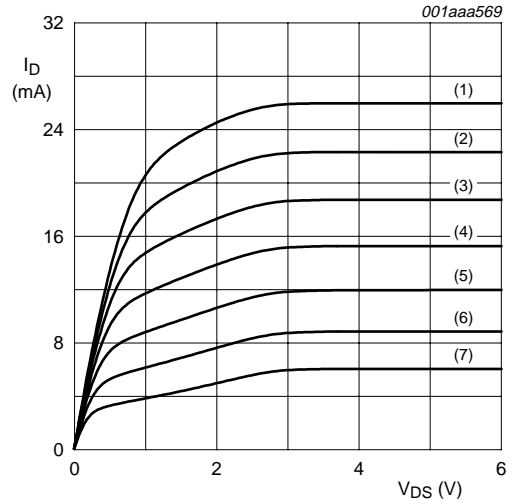
8.2.1 Graphs for amplifier b



- (1)  $V_{G2-S} = 4 \text{ V}$ .
- (2)  $V_{G2-S} = 3.5 \text{ V}$ .
- (3)  $V_{G2-S} = 3 \text{ V}$ .
- (4)  $V_{G2-S} = 2.5 \text{ V}$ .
- (5)  $V_{G2-S} = 2 \text{ V}$ .
- (6)  $V_{G2-S} = 1.5 \text{ V}$ .
- (7)  $V_{G2-S} = 1 \text{ V}$ .

$V_{DS(b)} = 5 \text{ V}$ ;  $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

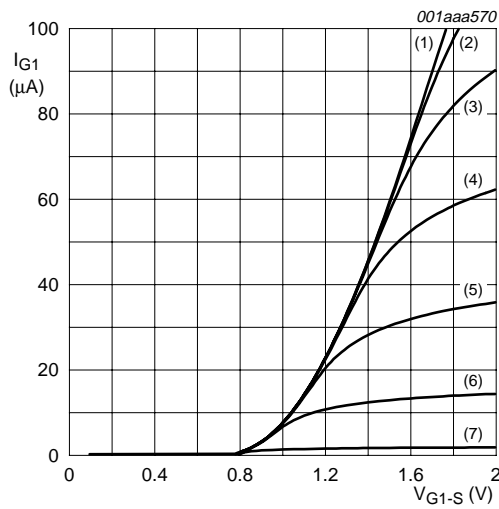
Fig 17. Transfer characteristics; typical values.



- (1)  $V_{G1-S(b)} = 1.6 \text{ V}$ .
- (2)  $V_{G1-S(b)} = 1.5 \text{ V}$ .
- (3)  $V_{G1-S(b)} = 1.4 \text{ V}$ .
- (4)  $V_{G1-S(b)} = 1.3 \text{ V}$ .
- (5)  $V_{G1-S(b)} = 1.2 \text{ V}$ .
- (6)  $V_{G1-S(b)} = 1.1 \text{ V}$ .
- (7)  $V_{G1-S(b)} = 1 \text{ V}$ .

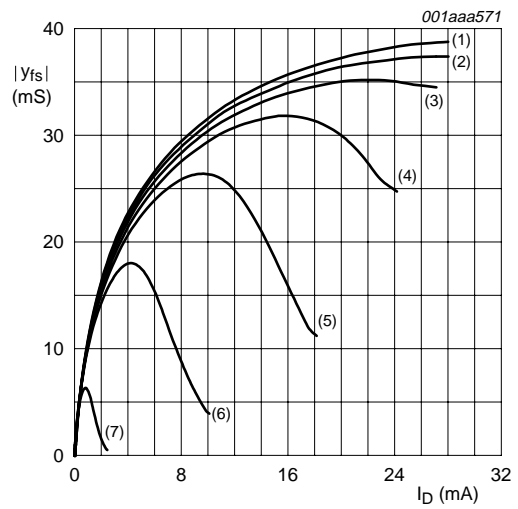
$V_{G2-S} = 4 \text{ V}$ ;  $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

Fig 18. Output characteristics; typical values.



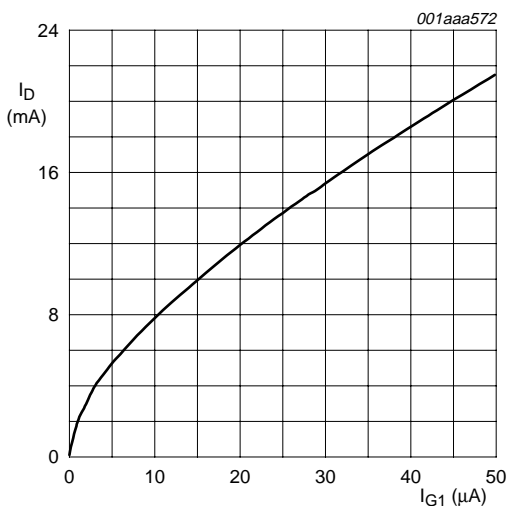
(1)  $V_{G2-S} = 4 \text{ V}$ .  
 (2)  $V_{G2-S} = 3.5 \text{ V}$ .  
 (3)  $V_{G2-S} = 3 \text{ V}$ .  
 (4)  $V_{G2-S} = 2.5 \text{ V}$ .  
 (5)  $V_{G2-S} = 2 \text{ V}$ .  
 (6)  $V_{G2-S} = 1.5 \text{ V}$ .  
 (7)  $V_{G2-S} = 1 \text{ V}$ .  
 $V_{DS(b)} = 5 \text{ V}$ ;  $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

Fig 19. Gate 1 current as a function of gate 1 voltage; typical values.



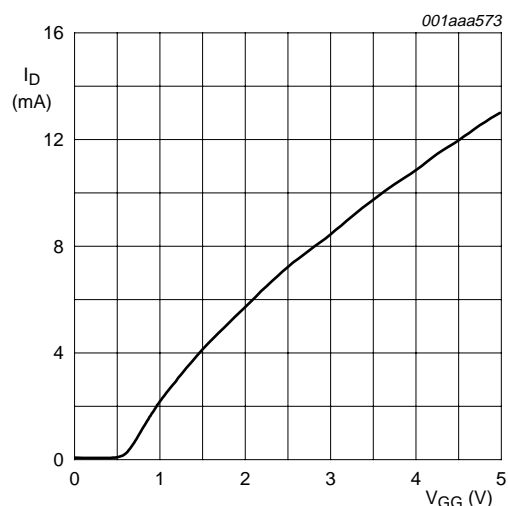
(1)  $V_{G2-S} = 4 \text{ V}$ .  
 (2)  $V_{G2-S} = 3.5 \text{ V}$ .  
 (3)  $V_{G2-S} = 3 \text{ V}$ .  
 (4)  $V_{G2-S} = 2.5 \text{ V}$ .  
 (5)  $V_{G2-S} = 2 \text{ V}$ .  
 (6)  $V_{G2-S} = 1.5 \text{ V}$ .  
 (7)  $V_{G2-S} = 1 \text{ V}$ .  
 $V_{DS(b)} = 5 \text{ V}$ ;  $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ .

Fig 20. Forward transfer admittance as a function of drain current; typical values.



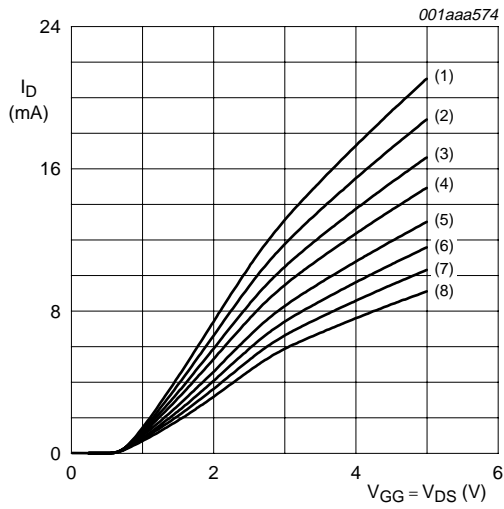
$V_{DS(b)} = 5 \text{ V}$ ;  $V_{G2-S} = 4 \text{ V}$ ;  $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$ ;  
 $T_j = 25 \text{ }^\circ\text{C}$ .

Fig 21. Drain current as a function of gate 1 current; typical values.



$V_{DS(b)} = 5 \text{ V}$ ;  $V_{G2-S} = 4 \text{ V}$ ;  $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$ ;  
 $T_j = 25 \text{ }^\circ\text{C}$ ;  $R_{G1(b)} = 150 \text{ k}\Omega$  (connected to  $V_{GG}$ ); see Figure 3.

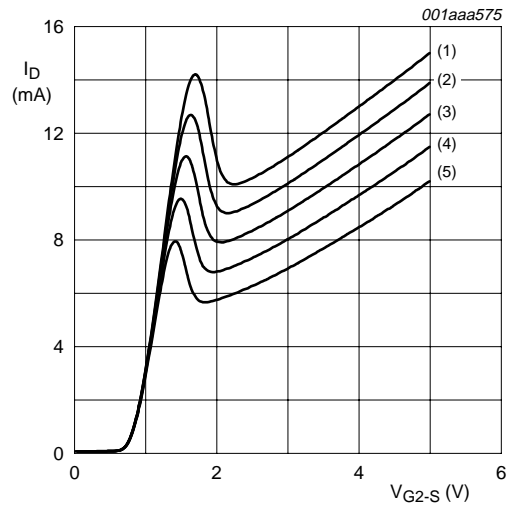
Fig 22. Drain current as a function of gate 1 supply voltage ( $V_{GG}$ ); typical values.



- (1)  $R_{G1(b)} = 68 \text{ k}\Omega$ .
- (2)  $R_{G1(b)} = 82 \text{ k}\Omega$ .
- (3)  $R_{G1(b)} = 100 \text{ k}\Omega$ .
- (4)  $R_{G1(b)} = 120 \text{ k}\Omega$ .
- (5)  $R_{G1(b)} = 150 \text{ k}\Omega$ .
- (6)  $R_{G1(b)} = 180 \text{ k}\Omega$ .
- (7)  $R_{G1(b)} = 220 \text{ k}\Omega$ .
- (8)  $R_{G1(b)} = 270 \text{ k}\Omega$ .

$V_{G2-S} = 4 \text{ V}$ ;  $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ ;  
 $R_{G1(b)}$  is connected to  $V_{GG}$ ; see [Figure 3](#).

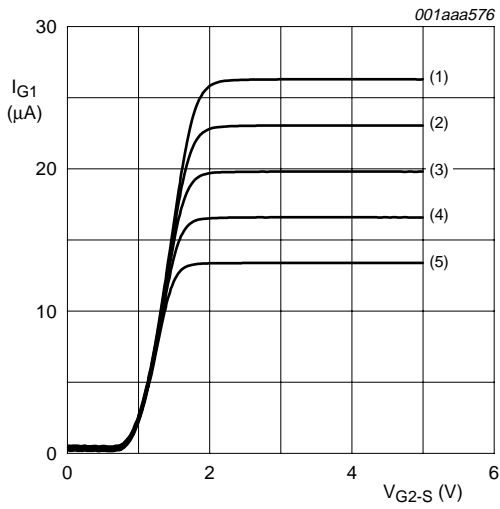
**Fig 23. Drain current as a function of gate 1 ( $V_{GG}$ ), drain supply voltage and value of  $R_{G1}$ ; typical values.**



- (1)  $V_{GG} = 5.0 \text{ V}$ .
- (2)  $V_{GG} = 4.5 \text{ V}$ .
- (3)  $V_{GG} = 4.0 \text{ V}$ .
- (4)  $V_{GG} = 3.5 \text{ V}$ .
- (5)  $V_{GG} = 3.0 \text{ V}$ .

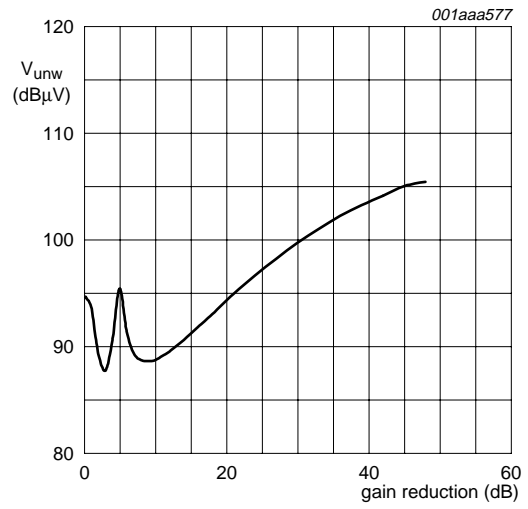
$V_{DS(b)} = 5 \text{ V}$ ;  $V_{DS(a)} = V_{G1-S(a)} = 0 \text{ V}$ ;  $T_j = 25 \text{ }^\circ\text{C}$ ;  
 $R_{G1(b)} = 150 \text{ k}\Omega$  (connected to  $V_{GG}$ ); see [Figure 3](#).

**Fig 24. Drain current as a function of gate 2 voltage; typical values.**



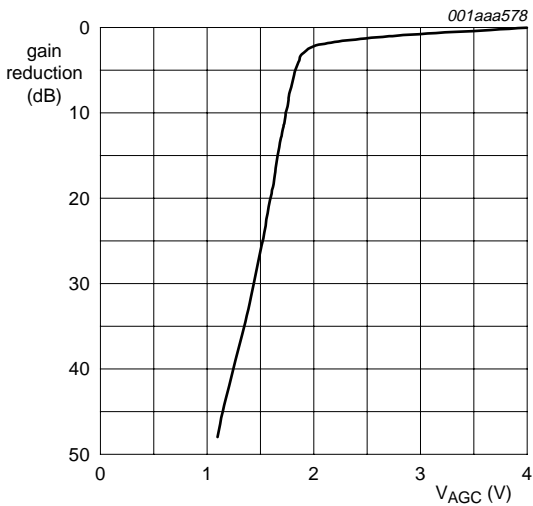
(1)  $V_{GG} = 5.0$  V.  
 (2)  $V_{GG} = 4.5$  V.  
 (3)  $V_{GG} = 4.0$  V.  
 (4)  $V_{GG} = 3.5$  V.  
 (5)  $V_{GG} = 3.0$  V.  
 $V_{DS(b)} = 5$  V;  $V_{DS(a)} = V_{G1-S(a)} = 0$  V;  $T_j = 25$  °C;  
 $R_{G1(b)} = 150$  k $\Omega$  (connected to  $V_{GG}$ ); see [Figure 3](#).

**Fig 25. Gate 1 current as a function of gate 2 voltage; typical values.**



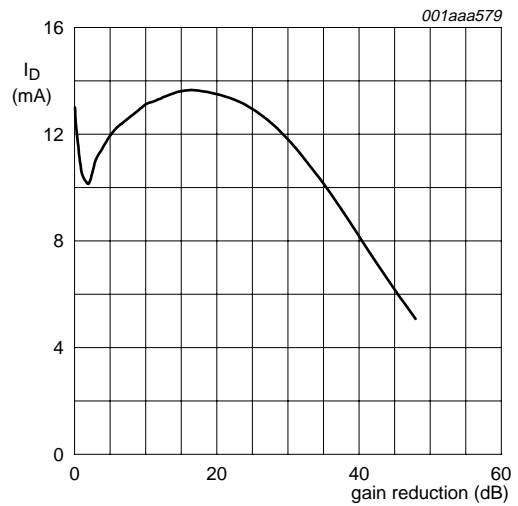
$V_{DS(b)} = 5$  V;  $V_{GG} = 5$  V;  $V_{DS(a)} = V_{G1-S(a)} = 0$  V;  
 $R_{G1(b)} = 150$  k $\Omega$  (connected to  $V_{GG}$ );  $f_w = 50$  MHz;  
 $f_{unw} = 60$  MHz;  $T_{amb} = 25$  °C; see [Figure 34](#).

**Fig 26. Unwanted voltage for 1 % cross-modulation as a function of gain reduction; typical values.**



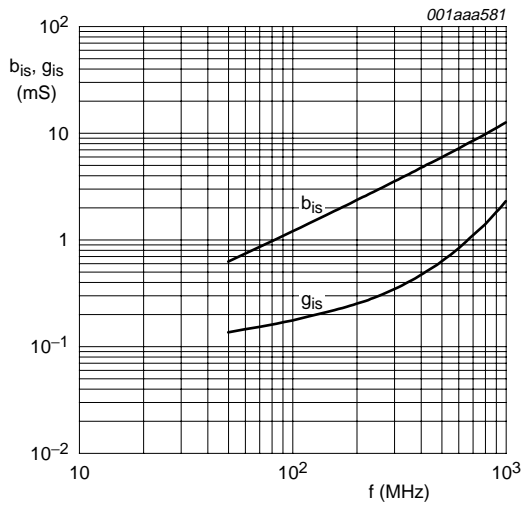
$V_{DS(b)} = 5$  V;  $V_{GG} = 5$  V;  $V_{DS(a)} = V_{G1-S(a)} = 0$  V;  
 $R_{G1(b)} = 150$  k $\Omega$  (connected to  $V_{GG}$ );  $f = 50$  MHz;  
 $T_{amb} = 25$  °C; see [Figure 34](#).

**Fig 27. Typical gain reduction as a function of AGC voltage.**



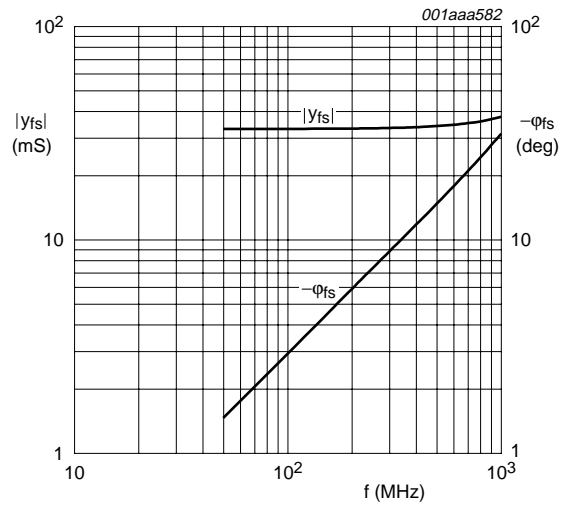
$V_{DS(b)} = 5$  V;  $V_{GG} = 5$  V;  $V_{DS(a)} = V_{G1-S(a)} = 0$  V;  
 $R_{G1(b)} = 150$  k $\Omega$  (connected to  $V_{GG}$ );  $f = 50$  MHz;  
 $T_{amb} = 25$  °C; see [Figure 34](#).

**Fig 28. Drain current as a function of gain reduction; typical values.**



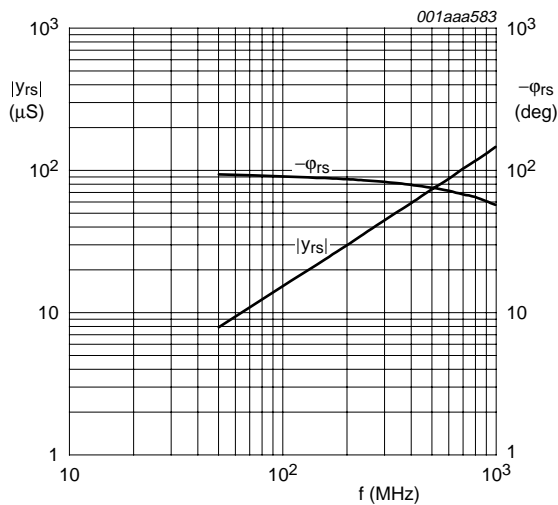
$V_{DS(b)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(a)} = V_{G1-S(a)} = 0\text{ V}; I_{D(b)} = 13\text{ mA}.$

Fig 29. Input admittance as a function of frequency; typical values.



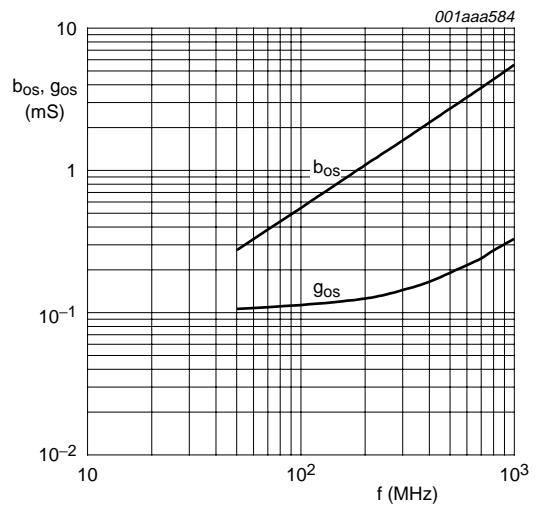
$V_{DS(b)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(a)} = V_{G1-S(a)} = 0\text{ V}; I_{D(b)} = 13\text{ mA}.$

Fig 30. Forward transfer admittance and phase as a function of frequency; typical values.



$V_{DS(b)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(a)} = V_{G1-S(a)} = 0\text{ V}; I_{D(b)} = 13\text{ mA}.$

Fig 31. Reverse transfer admittance and phase as a function of frequency; typical values.



$V_{DS(b)} = 5\text{ V}; V_{G2-S} = 4\text{ V}; V_{DS(a)} = V_{G1-S(a)} = 0\text{ V}; I_{D(b)} = 13\text{ mA}.$

Fig 32. Output admittance as a function of frequency; typical values.



### 8.2.2 Scattering parameters for amplifier b

**Table 12. Scattering parameters for amplifier b**

$V_{DS(b)} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_{D(b)} = 13\text{ mA}$ ;  $V_{DS(a)} = 0\text{ V}$ ;  $V_{G1-S(a)} = 0\text{ V}$ ;  $T_{amb} = 25\text{ °C}$ .

f (MHz)	S <sub>11</sub>		S <sub>21</sub>		S <sub>12</sub>		S <sub>22</sub>	
	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)	Magnitude ratio	Angle (deg)
50	0.986	-3.66	3.26	175.93	0.0008	84.23	0.988	-1.65
100	0.982	-7.01	3.24	172.04	0.0015	84.91	0.988	-3.27
200	0.975	-13.71	3.22	164.24	0.0029	83.96	0.986	-6.50
300	0.966	-20.36	3.19	156.53	0.0042	82.86	0.984	-9.69
400	0.955	-27.04	3.15	148.86	0.0055	81.88	0.982	-12.88
500	0.943	-33.62	3.10	141.24	0.0066	80.92	0.978	-16.07
600	0.927	-40.16	3.05	133.70	0.0076	80.15	0.975	-19.21
700	0.909	-46.70	2.99	126.13	0.0086	79.68	0.972	-22.35
800	0.891	-52.07	2.92	118.64	0.0094	78.28	0.968	-25.52
900	0.868	-59.48	2.84	111.09	0.0100	78.28	0.965	-28.65
1000	0.846	-65.86	2.77	103.58	0.0107	78.15	0.961	-31.85

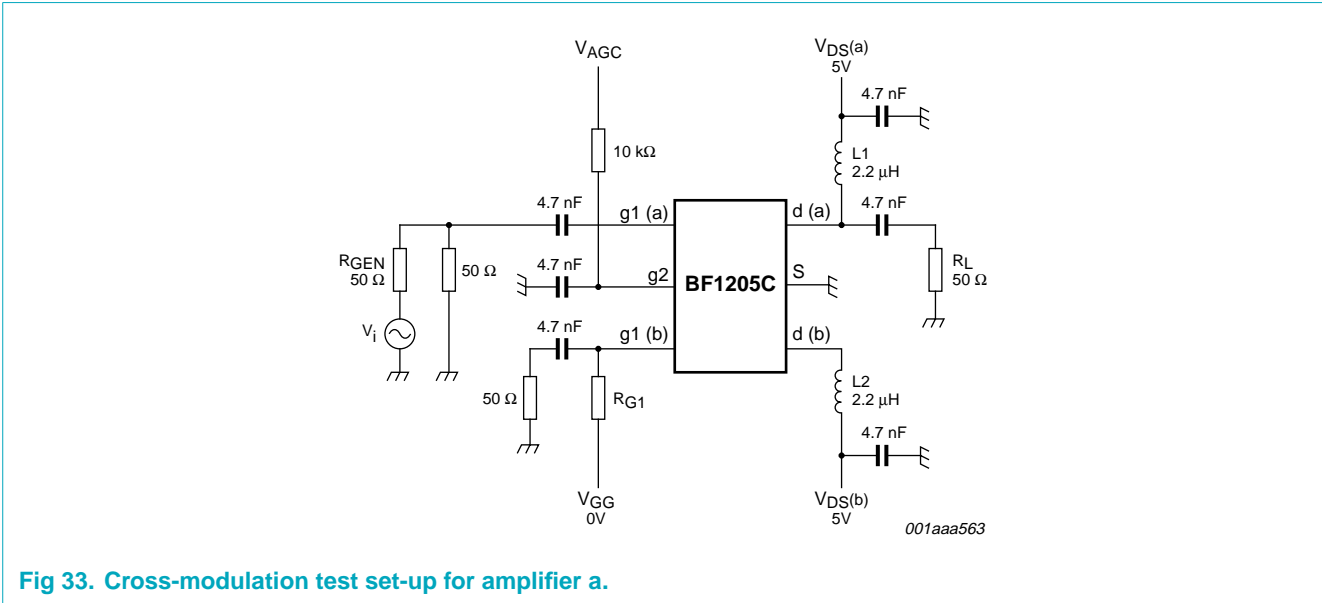
### 8.2.3 Noise data for amplifier b

**Table 13. Noise data for amplifier b**

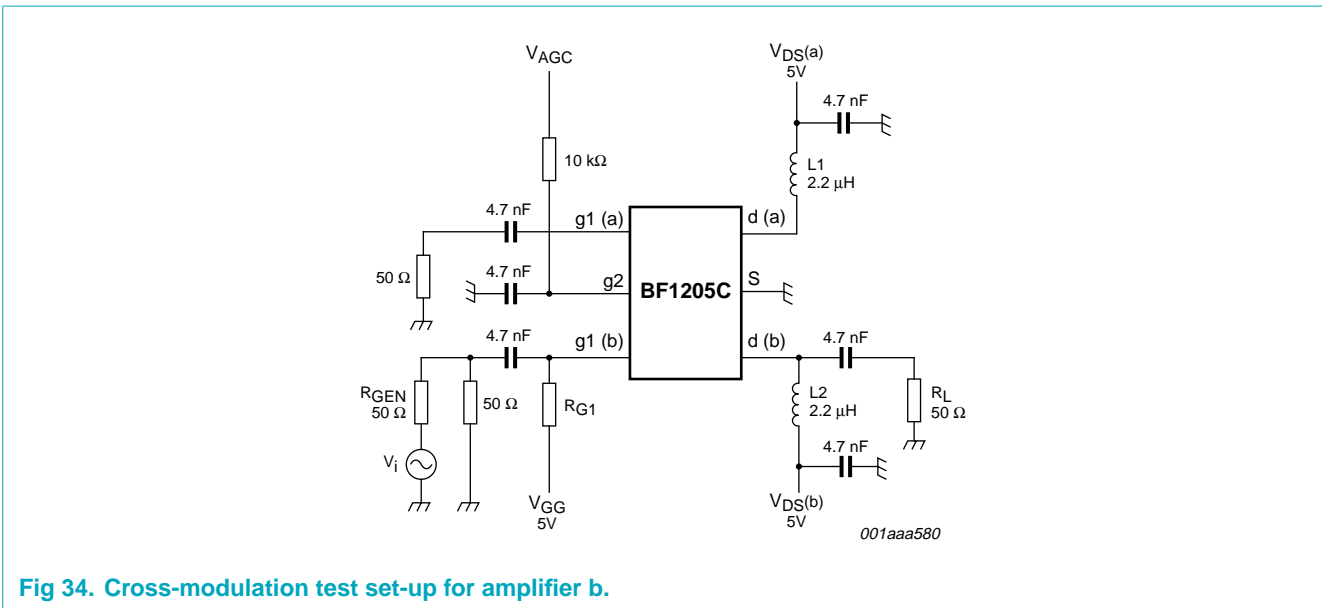
$V_{DS(b)} = 5\text{ V}$ ;  $V_{G2-S} = 4\text{ V}$ ;  $I_{D(b)} = 13\text{ mA}$ ;  $V_{DS(a)} = 0\text{ V}$ ;  $V_{G1-S(a)} = 0\text{ V}$ ;  $T_{amb} = 25\text{ °C}$ .

f (MHz)	F <sub>min</sub> (dB)	Γ <sub>opt</sub>		r <sub>n</sub> (Ω)
		ratio	(deg)	
400	1.3	0.695	13.11	0.694
800	1.4	0.674	32.77	0.674

**9. Test information**



**Fig 33. Cross-modulation test set-up for amplifier a.**



**Fig 34. Cross-modulation test set-up for amplifier b.**

**10. Package outline**

Plastic surface-mounted package; 6 leads

SOT363

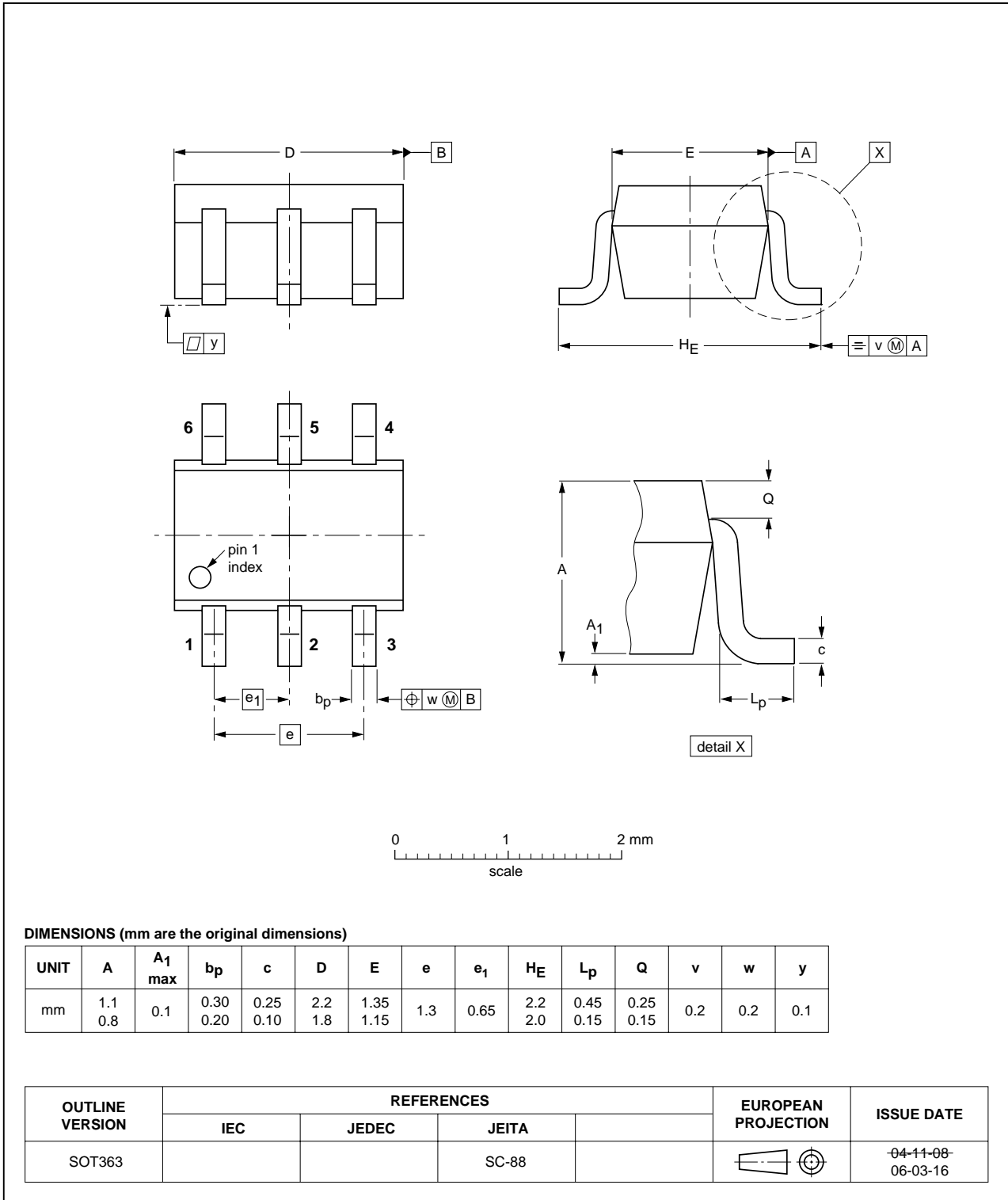


Fig 35. Package outline.

## 11. Revision history

Table 14. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BF1205C_2	20060815	Product data sheet	-	BF1205C_1 (9397 750 13005)
Modifications:	• <a href="#">Figure 1</a> : replaced drawing with correct drawing 001aac193			
BF1205C_1 (9397 750 13005)	20040518	Product data sheet	-	-

## 12. Legal information

### 12.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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## 14. Contents

<b>1</b>	<b>Product profile</b> . . . . .	<b>1</b>
1.1	General description . . . . .	1
1.2	Features . . . . .	1
1.3	Applications . . . . .	1
1.4	Quick reference data . . . . .	2
<b>2</b>	<b>Pinning information</b> . . . . .	<b>2</b>
<b>3</b>	<b>Ordering information</b> . . . . .	<b>3</b>
<b>4</b>	<b>Marking</b> . . . . .	<b>3</b>
<b>5</b>	<b>Limiting values</b> . . . . .	<b>3</b>
<b>6</b>	<b>Thermal characteristics</b> . . . . .	<b>3</b>
<b>7</b>	<b>Static characteristics</b> . . . . .	<b>4</b>
<b>8</b>	<b>Dynamic characteristics</b> . . . . .	<b>5</b>
8.1	Dynamic characteristics for amplifier a . . . . .	5
8.1.1	Graphs for amplifier a . . . . .	6
8.1.2	Scattering parameters for amplifier a . . . . .	10
8.1.3	Noise data for amplifier a . . . . .	10
8.2	Dynamic characteristics for amplifier b . . . . .	11
8.2.1	Graphs for amplifier b . . . . .	12
8.2.2	Scattering parameters for amplifier b . . . . .	17
8.2.3	Noise data for amplifier b . . . . .	17
<b>9</b>	<b>Test information</b> . . . . .	<b>18</b>
<b>10</b>	<b>Package outline</b> . . . . .	<b>19</b>
<b>11</b>	<b>Revision history</b> . . . . .	<b>20</b>
<b>12</b>	<b>Legal information</b> . . . . .	<b>21</b>
12.1	Data sheet status . . . . .	21
12.2	Definitions . . . . .	21
12.3	Disclaimers . . . . .	21
12.4	Trademarks . . . . .	21
<b>13</b>	<b>Contact information</b> . . . . .	<b>21</b>
<b>14</b>	<b>Contents</b> . . . . .	<b>22</b>

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